Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/254,152	HIGASHIYAMA ET AL.	
Examiner	Art Unit	
Shengjun Wang	1617	

SEARCHED						
Class	Subclass	Date	Examiner			
514	560,546	2/18/2006	sw			
435	135,134	2/18/2006	SW			
552	544	2/18/2006	sw			
554	1	2/18/2006	sw			
426	648,801	2/18/2006	SW			
426	807					

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
514	560,546	2/18/2006	sw			
435	135,134	2/18/2006	sw			
554	1	2/18/2006	sw			
552/544; 426/648,801,807		2/18/2006	sw			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
apdater inventor	418/06	ςω	
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